

# STS15N4LLF3

#### **General features**

Type V <sub>DS</sub>		R <sub>DS(on)</sub>	I <sub>D</sub>
STS15N4LLF3	40V	<0.005Ω	15A

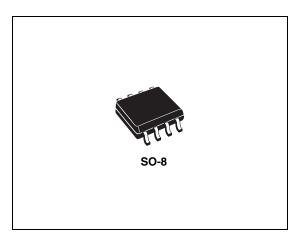
- Optimal R<sub>DS(on)</sub>x Q<sub>g</sub> trade-off @ 4.5V
- Conduction losses reduced
- Switching losses reduced

### Description

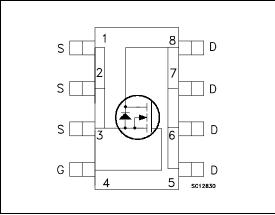
This N-channel enhancement mode Power MOSFET is the latest refinement of STMicroelectronic unique "Single Feature Size™" strip-based process with less critical aligment steps and therefore a remarkable manufacturing reproducibility. The resulting transistor shows extremely high packing density for low onresistance, rugged avalanche characteristics and low gate charge.

## **Applications**

Switching application



## Internal schematic diagram



#### Order codes

Part number	Marking	Package	Packaging
STS15N4LLF3	15N4LL-	SO-8	Tape & reel

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## 1 Electrical ratings

Table 1. Absolute maximim ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	40	V
V <sub>GS</sub>	Gate-source voltage	± 16	V
V <sub>GS</sub> <sup>(1)</sup>	Gate- source voltage	±18	V
Ι <sub>D</sub>	Drain current (continuous) at $T_{C} = 25^{\circ}C$	15	А
Ι <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100°C	9.3	А
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	60	А
P <sub>TOT</sub>	Total dissipation at $T_{C} = 25^{\circ}C$	2.7	W
E <sub>AS</sub> <sup>(3)</sup>	Single pulse avalanche energy	2	J

1. Guaranteed for test time  $\leq$  15ms

2. Pulse width limited by Tjmax

3. Starting  $T_j = 25^{\circ}C$ ,  $I_D = 7.5A$ ,  $V_{DD} = 25V$ 

#### Table 2. Thermal resistance

Symbol	Parameter	Value	Unit
R <sub>thj</sub> -pcb <sup>(1)</sup>	Thermal resistance junction-pcb max	47	°C/W
Τ <sub>Ι</sub>	Maximum lead temperature for soldering	-55 to 150	°C
T <sub>stg</sub>	Storage temperature	-55 to 150	°C

1. When mounted of FR-4 board with 1 inch<sup>2</sup> pad, 2oz of Cu and t< 10sec



## 2 Electrical characteristics

(T<sub>J</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_{D} = 250 \mu A, V_{GS} = 0$	40			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = max rating, V <sub>DS</sub> =max rating @125°C			10 100	μΑ μΑ
I <sub>GSS</sub>	Gate body leakage Current (V <sub>DS</sub> = 0)	$V_{GS} = \pm 16V$			±200	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1			V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 7.5A V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 7.5A		0.0042 0.005	0.005 0.007	Ω Ω

#### Table 3.On/off states

#### Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> = 25V, f=1 MHz, V <sub>GS</sub> = 0		2530 574 29		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 20V, I_D = 15A$ $V_{GS} = 4.5V$ (see Figure 13)		21.5 6.9 8.2	28	nC nC nC
R <sub>G</sub>	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20mV open drain	1	3	5	Ω

#### Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time Rise time	$\begin{split} V_{DD} &= 20V, \ I_D = 7.5A, \\ R_G &= 4.7\Omega, \ V_{GS} = 10V \\ (see \ Figure \ 15) \end{split}$		17 25		ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off delay time Fall time	$\begin{split} V_{DD} &= 20V, \ I_D = 7.5A, \\ R_G &= 4.7\Omega, \ V_{GS} = 10V \\ (see \ Figure \ 15) \end{split}$		62 9		ns ns

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)				15 60	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 15A, V_{GS} = 0$			1.2	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$\begin{split} I_{SD} &= 15A, \ V_{DD} = 30V, \\ di/dt &= 100A/\mu s, \\ Tj &= 150^{\circ}C \ (see \ Figure \ 14) \end{split}$		43 64 3		ns nC A

 Table 6.
 Source drain diode

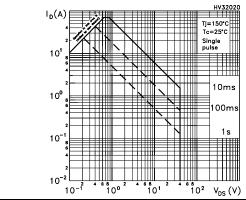
1. Pulse width limited by safe operating area

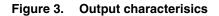
2. Pulsed: pulse duration =  $300\mu s$ , duty cycle 1.5%



#### **Electrical characteristics (curves)** 2.1

#### Figure 1. Safe operating area





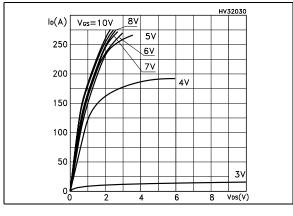
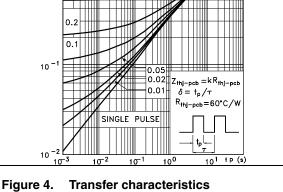


Figure 5. Normalized B<sub>VDSS</sub> vs temperature



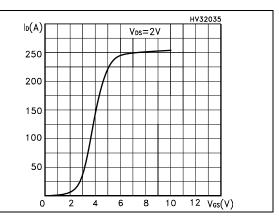
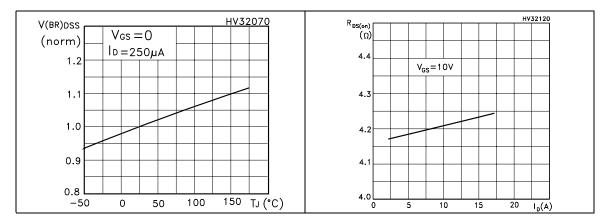


Figure 6. Static drain-source on resistance

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к  $\delta = 0.5$ 

Figure 2. Thermal impedance

VGS(th)

1.2

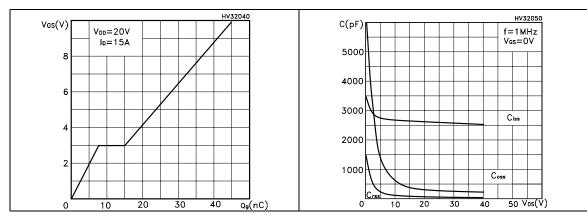
1.0

0.8

0.6

0.4

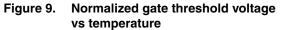
(norm)



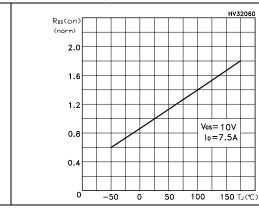
#### Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

HV32080

Vos=Vos Io=250µA

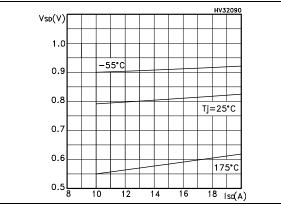






0.2 -50 0 50 100 150 TJ (°C)

Figure 11. Source-drain diode forward characteristics



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## 3 Test circuit

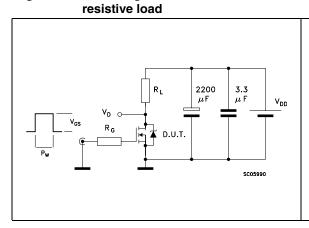
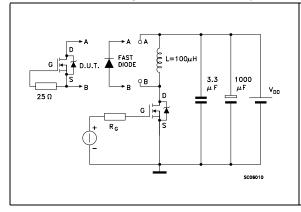
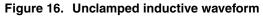


Figure 14. Test circuit for inductive load switching and diode recovery times





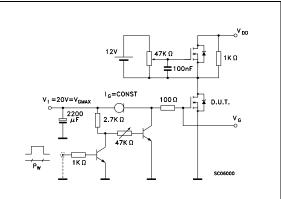
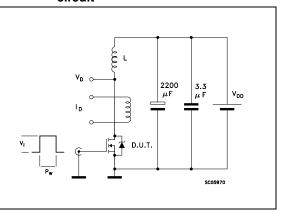
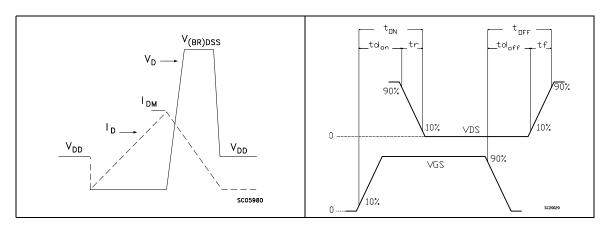


Figure 15. Unclamped Inductive load test circuit









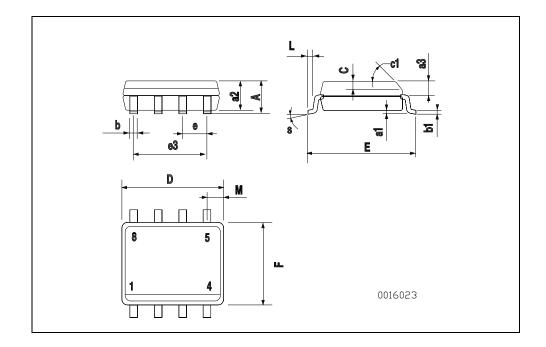
# Figure 12. Switching times test circuit for Figure 13. Gate charge test circuit

## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: twww.st.com



	SO-8 MECHANICAL DATA					
DIM.		mm.			inch	
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1		•	45	(typ.)	•	
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023
S		•	8 (r	nax.)	•	



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# 5 Revision history

Table 7. Revision history

Date	Revision	Changes
09-Jun-2006	1	First release
22-Nov-2006	2	Corrected part number



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